

VFPB010R067NA

Datasheet

VMDSEMI



VFPB010R067NA

General Description

Symbol

V _{(BR)DSS}	RDS(ON)_max	ID
100V	6.7mΩ@10V	120 4
	9.4mΩ@4.5V	120A

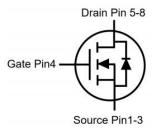


Figure 1 Symbol of VFPB010R067NA



Ordering Information

Product Name	Package		
VFPB010R067NA	PDFN5*6		



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Absolute Maximum Ratings (T_A= 25 °C, unless otherwise specified)

Parameter	Symbol	Rating	Unit	
Drain-Source Voltage		V _{DSS}	100	V
Gate-Source Voltage		V _{GSS}	±20	V
Continuous Drain Current	т	120	A	
Continuous Drain Current	T _C =100°C	— I _D	76	A
Pulsed Drain Current ^{Note 2}	$T_{C}=25^{\circ}C$	I _{D.pulse}	480	A
Continuous Diode Forward Current T _C =25°C		Is	120	A
Continuous Drain Current T _A =25°C		т	22	A
Continuous Drain Current	T _A =70°C	- I _{DSM}	18	A
Max Power Dissipation T _C =25°C		n	125	
Max Power Dissipation	Tc=100°C	– P _D	50	
Max Power Dissipation ^{Note 3}	T _A =25°C	D	4	W
Max Power Dissipation ^{Note 3}	T _A =70°C	P _{DSM}	2.7	
Avalanche Energy, Single Pulse Note 4	E _{AS}	121	mJ	
Operation and storage temperature	T _J ,T _{STG}	- <mark>5</mark> 5 to 150	°C	

Thermal Resistance

Parameter	Symbol	Min	Тур	Max	Unit
Thermal Resistance, Junction-to-Case	R _{θJC}		1.0	1.2	°C/W
Thermal Resistance, Junction-to-Ambient	R _{0JA}		30	36	

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Parameter		Symbol	Test Conditions	Min	Тур	Max	Unit	
Statistic Characteristics			1					
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, I _D =250uA	100			V	
Zero Gate Voltage Drain Current			V _{DS} =100V, V _{GS} =0V			1	uA	
Zero Gate Voltage Drain Curren	t T _J = 125 °C	I _{DSS}	V _{DS} =100V, V _{GS} =0V			100	uA	
Cotto Do to Logla of Comment	Forward	I _{GSSF}	V _{GS} =20V, V _{DS} =0V			100		
Gate-Body Leakage Current	Reverse	I _{GSSR}	V_{GS} =-20V, V_{DS} =0V			-100	nA	
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250uA	1.4	1.9	2.4	V	
Drain-Source On-Resistance ^{Note1}					4.8	6.7	mΩ	
Drain-Source On-Resistance ^{Note1} T _J = 100 °C		R _{DS(ON)}	$V_{GS}=10V, I_D=40A$		5			
Drain-Source On-Resistance ^{Note}	1		V _{GS} =4.5V, I _D =30A		6.7	9.4		
Gate resistance		R _G	f=1 MHz, Open drain	0.2	1.3	5	Ω	
Dynamic Characteristics								
Input Capacitance		C _{ISS}	V _{DS} =30V	3600	4240	4880	pF	
Output Capacitance		Coss	V _{GS} =0V	1360	1600	1840	pF	
Reverse Transfer Capacitance		C _{RSS}	f=1MHz	25	35	45	pF	
Turn-on Delay Time		t _{d(on)}	V _{DS} =50V		13			
Rise Time		tr	I _D =50A		45		ns	
Turn-off Delay Time		t _{d(off)}	$R_G=3\Omega$		39			
Fall Time		t _f	V _{GS} =10V		42			
Gate Charge Characteristics								
Gate to Source Charge		Qgs	V -10V		14	19		
Gate to Drain Charge		Q_{gd}	$V_{GS}=10V$		6.8	10	nC	
Gate Charge Total@V _{GS} =10V		– Qg	$V_{DS}=50V$ $I_{D}=50A$		56	75		
Gate Charge Total@V _{GS} =4.5V			1D-30A		26	35		
Reverse Diode Characteristics								
Drain-Source Diode Forward Vo	oltage	V _{SD}	V _{GS} =0V, I _{SD} =40A		0.8	1.2	V	
Reverse Recovery Time		t _{rr}	I _{SD} =50A V _{GS} =0V		50	100	ns	
Reverse Recovery Charge	VIL	Qrr	di/dt=100A/us		53	106	nC	

Electrical Characteristics(T_J= 25 °C, unless otherwise specified)

Notes:

1. Pulse width $\leq 380 \mu s$; duty cycle $\leq 2\%$.

2. Repetitive rating; pulse width limited by max junction temperature.

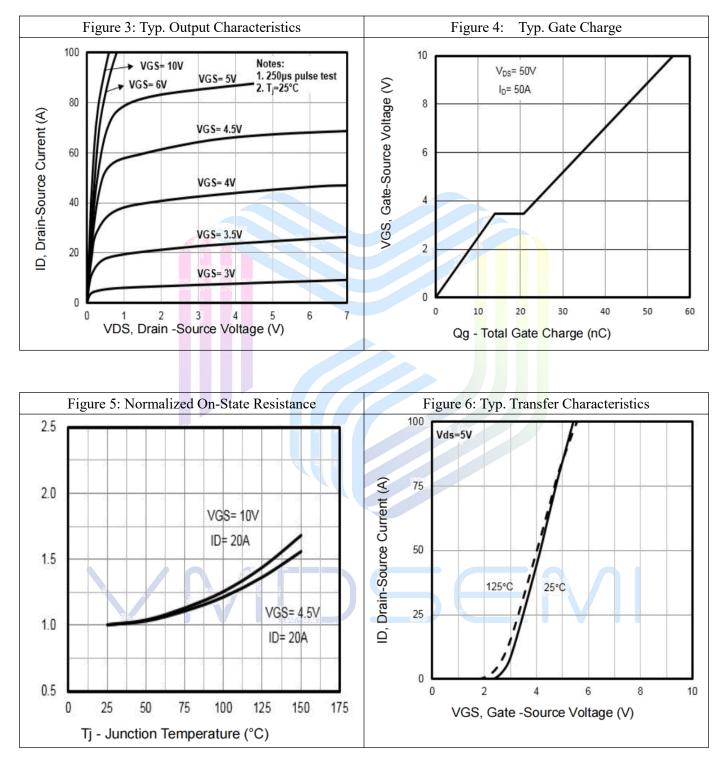
3. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C.

4. Limited by T_{Jmax} , starting $T_J = 25^{\circ}$ C, L = 0.5mH, $R_G = 25\Omega$, $I_{AS} = 22$ A, $V_{GS} = 10$ V.



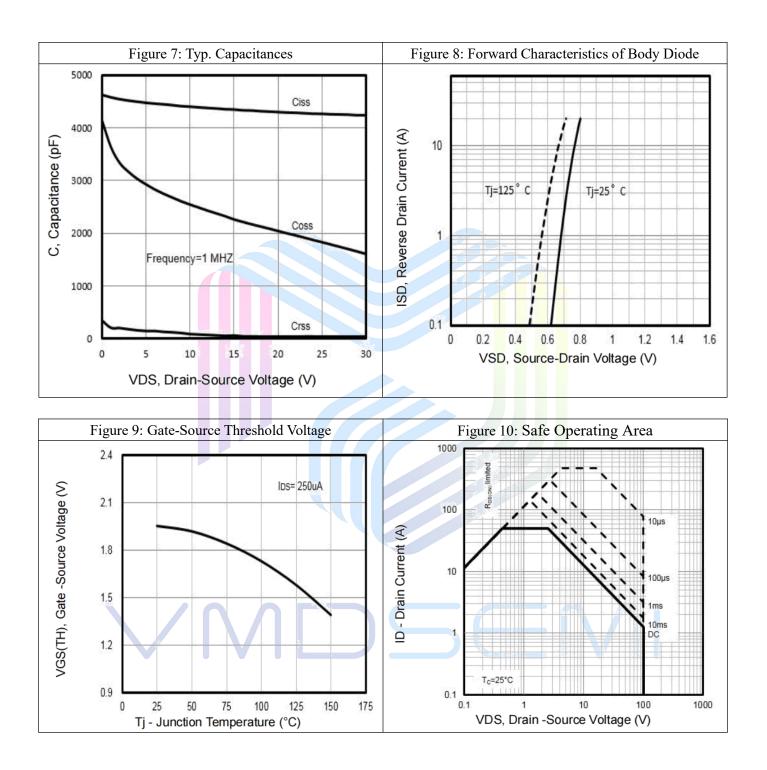
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Typical Performance Characteristics



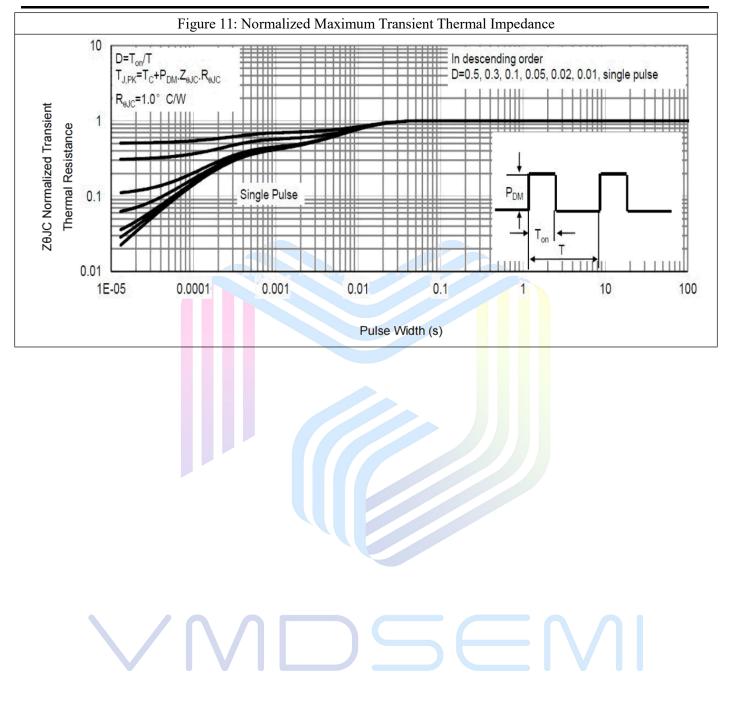


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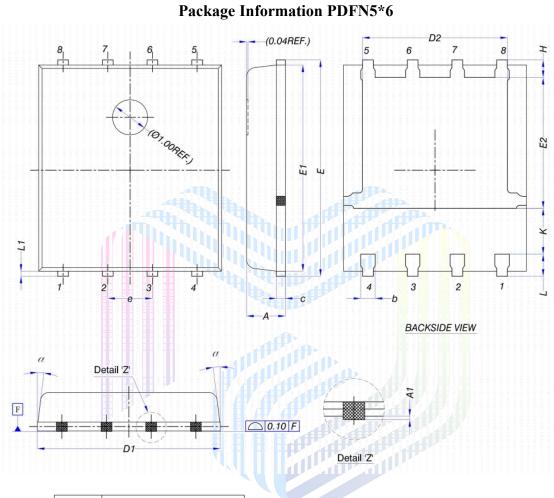
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Mechanical Dimensions



	Cum h al	DIMENSIONS (unit : mm)					
	Symbol	Min	Тур	Max			
	Α	1.00	1.10	1.20			
	A1	0.00		0.05			
	b	0.30	0.40	0.50			
	С	0.20	0.25	0.30			
	D1	5.00	5.20	5.40			
V	D2	3.80	4.10	4.25 6.35			
	E	5. <mark>9</mark> 5	6.15				
	E1	5.66	5.86	6.06			
	E2	3.52	3.72	3.92			
	е	1.27 BSC					
	н	0.40	0.50	0.60			
	к	1.10					
	L	0.50	0.60	0.70			
	L1	0.08	0.15	0.22			
	α	0°		12°			

Notes:

1. Refer to JEDEC MO-240 variation AA.

3. Dimensions "D1" and "E1" include interterminal flash or protrusion. Interterminal flash or protrusion shall not exceed 0.25mm per side.

^{2.} Dimensions "D1" and "E1" do NOT include mold flash protrusions or gate burrs.



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